

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	10905	stray\$4 near10 light\$6	US-PGPUB; USPAT	OR	ON	2005/08/01 16:33
L2	1303	1 same(correction\$3 or adjust\$4 or enhanc\$6)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:23
L3	152	2 same(color\$3)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:24
L4	157	2 same(color\$3 or colour\$2)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:34
L5	4	4 same(gray\$4 or grey\$4)	US-PGPUB; USPAT	OR	ON	2005/08/01 17:53
L6	844	(stray\$4 near10 light\$6)and(colour\$3 or color\$3)and(gray\$3 or grey\$4)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:25
L7	781	6 and(correct\$6 or adjust\$6 or enhanc\$6)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:27
L8	44	7 and(solid\$6 near10 array\$3)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:28
L9	44	8 and(calculat\$6 or multipl\$3 or comput\$6 or subtract\$4)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:35
L10	10	9 and(bright\$6 near10(compar\$6 or correlat\$6 or match\$4))	US-PGPUB; USPAT	OR	ON	2005/08/01 16:35
L11	47782	((stray\$4 or reflect\$6) near10 light\$6)same(correction\$3 or adjust\$6 or enhanc\$6)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:34
L12	6981	11 same(color\$3 or colour\$2)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:34
L13	273	12 same(gray\$4 or grey\$4)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:34
L14	204	13 and(calculat\$6 or multipl\$3 or comput\$6 or subtract\$4)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:35
L15	27	14 and(bright\$6 near10(compar\$6 or correlat\$6 or match\$4))	US-PGPUB; USPAT	OR	ON	2005/08/01 16:35
L16	1	"6396217".PN.	USPAT; USOCR	OR	ON	2005/08/01 17:53
L17	1	"6297859".PN.	USPAT; USOCR	OR	ON	2005/08/01 17:53
L18	1	"5760843".PN.	USPAT; USOCR	OR	ON	2005/08/01 17:53
L19	1	"5760843".PN.	USPAT; USOCR	OR	ON	2005/08/01 17:53
L20	1	"5287173".PN.	USPAT; USOCR	OR	ON	2005/08/01 17:53
L21	1	"6489601".PN.	USPAT; USOCR	OR	ON	2005/08/01 17:54

L22	1	"6301019".PN.	USPAT; USOCR	OR	ON	2005/08/01 17:54
L23	1	"6229627".PN.	USPAT; USOCR	OR	ON	2005/08/01 17:54

[Search Result - Print Format](#)[< Back t](#)

Key: IEEE JNL = IEEE Journal or Magazine, IEE JNL = IEE Journal or Magazine, IEEE CNF = IEEE Conference, IEE CNF = IEE Conference, IEEE STD = IEEE Standard

1. **In-situ n & k phase compensation in an interferometric flying height tester**
Womack, K.H.; Butler, A.;
Magnetics, IEEE Transactions on
Volume 34, Issue 2, March 1998 Page(s):459 - 461
IEEE JNL
2. **Anisotropy-corrected vegetation indexes derived from POLDER/ADEOS**
Leroy, M.; Hautecoeur, O.;
Geoscience and Remote Sensing, IEEE Transactions on
Volume 37, Issue 3, May 1999 Page(s):1698 - 1708
IEEE JNL
3. **Peak gain of a Cassegrain antenna with secondary position adjustment**
Zarghami, M.;
Antennas and Propagation, IEEE Transactions on [legacy, pre - 1988]
Volume 30, Issue 6, Nov 1982 Page(s):1228 - 1233
IEEE JNL
4. **Optimal surface adjustment of Haystack antenna**
Zarghami, M.S.; Antebi, J.; Kan, F.W.;
Antennas and Propagation, IEEE Transactions on
Volume 43, Issue 1, Jan. 1995 Page(s):79 - 86
IEEE JNL
5. **Digital imaging colposcopy: corrected area measurements using shape-from-shading**
Craine, B.L.; Craine, E.R.; O'Toole, C.J.; Qiang Ji;
Medical Imaging, IEEE Transactions on
Volume 17, Issue 6, Dec. 1998 Page(s):1003 - 1010
IEEE JNL
6. **Etched cavity InGaAsP-InP waveguide Fabry-Perot filter tunable by current injection**
Tsang, H.K.; Mak, M.W.K.; Chan, L.Y.; Soole, J.B.D.; Youtsey, C.; Adesida, I.;
Lightwave Technology, Journal of
Volume 17, Issue 10, Oct. 1999 Page(s):1890 - 1895
IEEE JNL
7. **Microphysical cross validation of spaceborne radar and ground polarimetric radar**
Chandrasekar, V.; Bolen, S.M.; Gorgucci, E.;
Geoscience and Remote Sensing, IEEE Transactions on
Volume 41, Issue 10, Oct. 2003 Page(s):2153 - 2165
IEEE JNL
8. **OSNR monitoring using double-pass filtering and dithered tunable reflector**
Chun-Liang Yang; San-Liang Lee;
Photonics Technology Letters, IEEE
Volume 16, Issue 6, June 2004 Page(s):1570 - 1572
IEEE JNL

9. **Precision of radio reflector surfaces adjusted from theodolite-tape measurements**
Greve, A.; Morris, D.; Johansson, L.E.B.; Whyborn, N.D.; Gluiber, A.;
Microwaves, Antennas and Propagation, IEE Proceedings -
Volume 141, Issue 1, Feb. 1994 Page(s):23 - 29
IEEE JNL
10. **Frequency domain measurement of the reflector impulse radiating antenna (IRA)**
Manteghi, M.; Rahmat-Samii, Y.; Bahadori, K.;
Antennas and Propagation Society Symposium, 2004. IEEE
Volume 3, 20-25 June 2004 Page(s):2955 - 2958 Vol.3
IEEE CNF
11. **Sub-pixel correction in comparison between in situ and satellite derived spectral reflectance**
Xiaobing Zhou; Shusun Li;
Geoscience and Remote Sensing Symposium, 2002. IGARSS '02. 2002 IEEE International
Volume 2, 24-28 June 2002 Page(s):976 - 978 vol.2
IEEE CNF
12. **Radar and lidar observations of the melting process in the bright band**
Venema, V.; Russchenberg, H.; Apituley, A.; van Lammeren, A.; Crewell, S.; Ligthart, L.;
Geoscience and Remote Sensing Symposium, 2000. Proceedings. IGARSS 2000. IEEE 2000 International
Volume 4, 24-28 July 2000 Page(s):1580 - 1583 vol.4
IEEE CNF
13. **Measurement of high-speed photodiodes using a microwave reflectometer to improve accuracy**
Gifford, A.D.; Humphreys, D.A.;
Measurements on Optical Devices, IEE Colloquium on
19 Nov 1992 Page(s):12/1 - 12/7
IEEE CNF
14. **Linear statistical models for stationary sequences and related algorithms for Cholesky factorization of Toeplitz matrices**
Demeure, C.; Scharf, L.;
Acoustics, Speech, and Signal Processing [see also IEEE Transactions on Signal Processing], IEEE Transactions on
Volume 35, Issue 1, Jan 1987 Page(s):29 - 42
IEEE JNL
15. **Atmospheric structure, transhorizon propagation, and their relationship to remote sensing**
Cianos, N.;
Antennas and Propagation, IEEE Transactions on [legacy, pre - 1988]
Volume 26, Issue 2, Mar 1978 Page(s):333 - 340
IEEE JNL
16. **Gains of finite-size corner-reflector antennas**
Cottany, H.; Wilson, A.;
Antennas and Propagation, IEEE Transactions on [legacy, pre - 1988]
Volume 6, Issue 4, Oct 1958 Page(s):366 - 369
IEEE JNL
17. **A New Four-Port Automatic Network Analyzer: Part II—Theory**
Brantervik, K.;
Microwave Theory and Techniques, IEEE Transactions on
Volume 33, Issue 7, Jul 1985 Page(s):569 - 575
IEEE JNL
18. **Delay-Line Based Techniques for Microwave and Millimeter-Wave Transmission/Reflection Test Sets**
Boulouard, A.;

Microwave Theory and Techniques, IEEE Transactions on
Volume 82, Issue 8, Aug 1982 Page(s):1174 - 1183
IEEE JNL

19. Internal Reflections In Dielectric Prisms

Fellers, R.G.; Taylor, J.;
Microwave Theory and Techniques, IEEE Transactions on
Volume 12, Issue 6, Nov 1964 Page(s):584 - 587
IEEE JNL

20. Accurate Phase-Length Measurements of Large Microwave Networks

Weaver, J.; Alvarez, R.;
Microwave Theory and Techniques, IEEE Transactions on
Volume 14, Issue 12, Dec 1966 Page(s):623 - 629
IEEE JNL

21. Magneto-optical properties of metallic bilayer thin films

Reim, W.; Weller, D.;
Magnetics, IEEE Transactions on
Volume 25, Issue 5, Sep 1989 Page(s):3752 - 3754
IEEE JNL

22. Pipeline architecture for block adaptive LS FIR filtering and prediction

Theodoridis, S.;
Acoustics, Speech, and Signal Processing [see also IEEE Transactions on Signal Processing], IEEE Transactions on
Volume 38, Issue 1, Jan. 1990 Page(s):81 - 90
IEEE JNL

23. Distributed Bragg reflector active optical filters

Tessler, N.; Nagar, R.; Eisenstein, G.; Salzman, J.; Koren, U.; Raybon, G.; Burns, C.A., Jr.;
Quantum Electronics, IEEE Journal of
Volume 27, Issue 8, Aug. 1991 Page(s):2016 - 2024
IEEE JNL

24. 100 GHz wafer probes based on photoconductive sampling

Feuer, M.D.; Shunk, S.C.; Smith, P.R.; Nuss, M.C.; Law, N.H.;
Photonics Technology Letters, IEEE
Volume 5, Issue 3, March 1993 Page(s):361 - 364
IEEE JNL

25. Corrections for the effects of a radome on antenna surface measurements made by microwave holography

Rogers, A.E.E.; Barvainis, R.; Charpentier, P.J.; Corey, B.E.;
Antennas and Propagation, IEEE Transactions on
Volume 41, Issue 1, Jan. 1993 Page(s):77 - 84
IEEE JNL